Analytical Reference Materials International



Certificate of Analysis Certified Reference Material

Grade: **Ti 2-1.5 / RA OT4-1**Part Number (Q.A. NO.): **IARM 367A**

Certificate Date: 04/21/2017 Certificate No.: 367A-04212017-IARM-F Revision Date: 10/10/2017

Interpretation of Data

- 1. Certified values listed below reflect analysis results submitted by qualified analytical laboratories using a combination of methods and instrumentation that emulate actual methods and instrumental techniques currently utilized in the analytical community and are reported as % wt. unless otherwise noted.
- 2. Any data reported and enclosed by a **parentheses** () is a "best estimate" and is **NOT CERTIFIED**. This data could not be quantified sufficiently for certification. It was however, reported by enough laboratories to be considered as potentially present in the matrix of the material being examined.
- 3. The "Inter laboratory Analysis Program" (ILAP) utilized in the establishment of the data are an ongoing program with permanent membership. Certain elements may be selected by a consensus of the members for more extensive testing. Therefore the data in **brackets** [] **indicates further testing is in process.**Chips are not certified for Hydrogen, Nitrogen, or Oxygen analysis.
- 4. The "±Estimated Uncertainty" is enclosed by a parentheses () below the individual element's concentration and is based on a Confidence Interval at 95%. Included in this estimated uncertainty, are the combined effects of method imprecision, material inhomogeneity, and any bias between methods.

Important: A "User Registration Card" accompanies all shipments. This card should be completed immediately upon receipt of materials with the appropriate user information. This is the only way in which ARMI can guarantee customer updates or possible data modifications!

<u>Aluminum</u>	Antimony	Boron	Carbon	Chromium	Cobalt	Copper	Hafnium	Hydrogen
2.02	(<0.0005)	(<0.001)	0.014	0.012	(<0.002)	0.002	(<0.001)	0.0030
(0.02)			(0.002)	(0.001)		(0.001)		(0.0003)
<u>Iron</u>	Lead	Magnesium	Manganese	Molybdenum	Nickel	<u>Niobium</u>	<u>Nitrogen</u>	<u>Oxygen</u>
0.064	(<0.001)	(<0.001)	1.61	0.0023	0.013	(<0.01)	0.0074	0.105
(0.004)			(0.05)	(0.0007)	(0.002)		(0.0003)	(0.005)
<u>Palladium</u>	Phosphorus	Ruthenium	Silicon	<u>Sulfur</u>	Tantalum	<u>Tin</u>	<u>Titanium</u>	Tungsten
(<0.01)	(<0.005)	(<0.01)	0.011	(0.0012)	(<0.005)	0.0019	(96.1)	(<0.002)
			(0.004)			(0.0005)		
<u>Vanadium</u>	<u>Yttrium</u>	Zirconium						
0.005	(<0.001)	0.003						
(0.001)		(0.001)						

The laboratories participating in the "Inter-Laboratory Analysis Program" (ILAP) and certification of this material are as follows:

Anderson Laboratories, Inc. - Greendale, WI NSL Analytical Services - Cleveland, OH

ATI Richland Operations - Richland, WA Oxford Instruments Analytical GmbH - Uedem, Germany

Exova - Middlesbrough, UK Perryman Company - Houston, PA

Exova Burlington Lab - Burlington, ON Special Metals IncoTest - Hereford, UK

Laboratory Testing, Inc. - Hatfield, PA

Timet - North American Operations - Henderson, NV

Leco Corporation - St. Joseph, MI

Timet - UK Limited - Witton, Birmingham, UK

Traceability: All members of the "Inter-Laboratory Analysis Program" (ILAP) listed above validate test methods and instrument performance utilizing SRMs produced by the National Institute of Standards and Technology, (NIST) as well as other CRMs and RMs produced by recognized Certifying Bodies from around the world. The specific SRMs, CRMs, and RMs applicable to the material covered by this certificate are:

ALPHA AR641	BCS 457/2	IARM 177B	IH ALLVAC BN3849	ECO 501-653	LECO 653	MBH 101XTI5	NIST 3114	NIST 3161a
ALPHA AR648	BCS 461/1	IARM 261A	IH ALLVAC HO73	LECO 501-657	LECO 762-741	MBH 101XTI6	NIST 3122	NIST 3163
ALPHA AR649	BCS 462/1	IARM 269A	IH ALLVAC W68B	LECO 501-664	MBH 101XT14	NIST 166C	NIST 3128	NIST 3165
ALPHA AR650	BS T13	IARM 271A	IH TI-2	LECO 501-674	MBH 101XTI1	NIST 173	NIST 3131a	NIST 647
ALPHA AR651	BS T22	IARM 285A	LECO 501	LECO 501-676	MBH 101XTI2	NIST 173C	NIST 3132	NIST 648
ALPHA AR689	GBW 02501	IARM 286A	LECO 501-024	LECO 501-995	MBH 101XTI3	NIST 174	NIST 3136	TI-RES
ALPHA AR892	IARM 174A	IARM 303A	LECO 501-320	LECO 502-135	MBH 101XTI4	NIST 2159	NIST 3137	VHG 44/03
BCS 356	IARM 175D	IARM 312B	LECO 501-502	LECO 502-201	MBH 101XTI4-A	NIST 3102a	NIST 3138	

A specific line of traceability is established to NIST and other Certifying Bodies for those elements that are noted as "Certified Values" on the Certificates of Analyses referenced above.

The following data and accompanying statements represent all pertinent information reported in the ILAP as it applies to the chemical characterization of this material as of 10/10/2017.

367A	Al	Sb	В	С	Cr	Co	Cu	Hf	Н	Fe	Pb	Mg	Mn	Мо	Ni	Nb
1	1.986	0.0001	0.0010	0.01021	0.009	0.0011	0.001	<0.0001	0.00259	0.0523	<0.0001	0.0004	1.487	0.001	0.008	0.002
2	1.9867			0.011	0.010		0.0017	< 0.0005	0.0028	0.0566	< 0.0005		1.53	0.0019	0.0093	0.0073
3	1.992			0.012	0.0103		0.0017		0.0029	0.061			1.5808	0.0020	0.0104	0.0090
4	1.9972			0.013	0.0109		0.0019		0.002915	0.062			1.583	0.002	0.011	
5	2.00			0.0135	0.0109		0.002		0.003	0.0635			1.587	0.0021	0.0113	
6	2.0040			0.0150	0.0119		0.0025		0.00329	0.064			1.6001	0.0027	0.0118	
7	2.021			0.015	0.012		0.0036		0.0036	0.0649			1.6019	0.0033	0.0119	
8	2.035			0.015815	0.0124					0.0650			1.6243	0.0036	0.0119	
9	2.0403			0.016066	0.0125					0.0657			1.6417		0.0120	
10	2.0710			0.0174	0.0130					0.0692			1.7030		0.0127	
11	2.093				0.0140					0.0715			1.742		0.0166	
12					0.0141					0.0725					0.0170	
13															0.0188	
14																
15																
Mean	2.02	0.0001	0.001	0.014	0.012	0.0011	0.002		0.0030	0.064		0.0004	1.61	0.0023	0.013	0.006
STDV.	0.04			0.002	0.002		0.001		0.0003	0.006			0.07	0.0008	0.003	0.004
Certified	2.02	(<0.0005)	(<0.001)	0.014	0.012	(<0.002)	0.002	(<0.001)	0.0030	0.064	(<0.001)	(<0.001)	1.61	0.0023	0.013	(<0.01)
95% C.I.	0.02			0.002	0.001		0.001		0.0003	0.004			0.05	0.0007	0.002	
Methods	X,O,I,G	IM	O,IM,I	С	X,O,IM,I,G	X,IM,I	X,O,I	IM	F	X,O,IM,I,G		IM,I	X,O,I,G	X,O,I	X,O,IM,I,G	X,O,IM,I

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES

367A	N	0	Pd	Р	Ru	Si	S	Та	Sn	Ti	W	V	Υ	Zr	
1	0.0070	0.0945	0.0025	0.001	0.001	0.004	0.0002	0.0012	0.0014	95.90	0.0015	0.0021	0.0001	0.0011	
2	0.007	0.098	0.008	0.0039	0.0071	0.0060	0.0013		0.0014	96.007		0.0038	0.0006	0.0015	
3	0.007	0.098				0.0065	0.0014		0.002	96.1158		0.0040		0.002	
4	0.0071	0.0995				0.0099	0.001785		0.002	96.1503		0.0040		0.0030	
5	0.0074	0.0999				0.0115			0.0023	96.22		0.0040		0.003	
6	0.0074	0.101				0.0129			0.0024			0.004		0.0049	
7	0.007769	0.1065				0.0143						0.0041			
8	0.0078	0.1089				0.0145						0.0050			
9	0.00802	0.113112				0.0182						0.0074			
10		0.114231										0.0077			
11		0.1167													
12															
13															
14															
15															
Mean	0.0074	0.105	0.005	0.002	0.004	0.011	0.0012	0.0012	0.0019	96.1	0.0015	0.005	0.0004	0.003	
STDV.	0.0004	0.008	0.004	0.002	0.004	0.005	0.0007		0.0004	0.1		0.002	0.0004	0.001	
Certified	0.0074	0.105	(<0.01)	(<0.005)	(<0.01)	0.011	(0.0012)	(<0.005)	0.0019	(96.1)	(<0.002)	0.005	(<0.001)	0.003	
95% C.I.	0.0003	0.005				0.004			0.0005			0.001		0.001	
Methods	G,F	G,F	X,O,IM,I	IM,I	O,IM,I	X,O,IM,I,G	С	X,O,IM,I	X,O,IM,I	O,I,Bal.	X,O,IM,I	X,O,IM,I	X,O,IM,I	X,O,IM	

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES

The International Standards Organization (ISO) definitions, expressed in ISO Guide 30-1992 list the following:

Certifying Body: Any technically competent body (organization or firm, public or private) that issues a reference material certificate, which provides the information, detailed in ISO Guide 31. The only generally accepted certifying body in the United States for primary standards - Standard Reference Materials (SRM) is the U. S. Department of Commerce, National Institute of Standards & Technology, (NIST), Gaithersburg, MD. All other certifying bodies in the United States produce Reference Materials (RM) or Certified Reference Materials (CRM).

Reference Material (RM): Material or substance one or more of whose property values are sufficiently homogeneous and well established to be used for the calibration of an apparatus, the assessment of a measurement method, or for assigning values to materials.

Certified Reference Material (CRM): Reference material, accompanied by a certificate, one or more of whose property values are certified by a procedure, which establishes its traceability to an accurate realization of the unit in which the property values are expressed, and for which each certified value is accompanied by an uncertainty at a stated level of confidence.

Inter-Laboratory Analysis Program (ILAP): Although ASTM Standard E691-87 applies to inter-laboratory studies to "Determine the Precision of a Single Test Method", it is also a well thought out and logical plan for conducting an inter laboratory program involving multiple techniques. Therefore, the planning, conducting, analyzing, protocol, and treatment of data resulting from this inter laboratory program were performed utilizing the guidelines established in ASTM E691-87.

Methods of Analysis: In view of the fact, that the "Inter Laboratory Analysis Program" entails a wide variety of materials, no single analytical method would provide optimum data results. Therefore, the methods utilized were a combination of ASTM Standard Methods for classical wet chemistry, ICP, AA, Optical Emission, and X-Ray spectrometric methods. The determinations for Carbon, Sulfur, Nitrogen, and Oxygen are the result of combustion and OE instrument procedures.

Expiration of Certification: The certification of this IARM is valid indefinitely, within the uncertainty specified, provided the IARM is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the IARM is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

Instructions for Use: The test surface is the side opposite to the labeled surface, which includes the IARM number. The entire thickness of the unit is certified. However, the user is cautioned not to measure disks less than 2 mm thick when using X-ray fluorescence spectrometry. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing as these processes may contaminate the surface. When not in use, the material should be stored in a cool, dry location. This material was tested using both the solid disks and chips prepared from the disks. The certified values are considered representative of the overall average composition of the material. Chips are not certified for Hydrogen, Nitrogen, or Oxygen analysis.

Selection of Materials: A "batch" or "series" is defined as a single bar of one continuous length and heat. The majority of materials are in wrought condition; other methods of manufacture are utilized as a less desirable resort. ILAP samples are taken by removing a section, a minimum of, every one-twelfth of total length from the entire bar. A portion of the section is converted to chips and thin (pin) disk for analysis by classical wet chemistry, ICP, AA, and combustion procedures, and the balance remains as a thick disk for OES and X-Ray analysis. This systematic sampling procedure results in the homogeneity being reflected as a product of the overall statistics and certified data. This method of homogeneity testing is in accordance with ISO Guide 34, regarding the systematic selection and testing of a representative number of units for the assessment of homogeneity.

David Coler, General Manager

Analytical Reference Materials International

ISO 9001:2008

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